

Search Notes

Application/Control No.

10/759,642

Examiner

PIERRE-LOUIS DESIR

Applicant(s)/Patent under
Reexamination

ERIC YEH ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	466	10/25/2008	PD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	10/25/2008	PD